

< High Voltage Insulated Gate Bipolar Transistor: HVIGBT >

CMH600DC-66X

HIGH POWER SWITCHING USE
INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

CMH600DC-66X



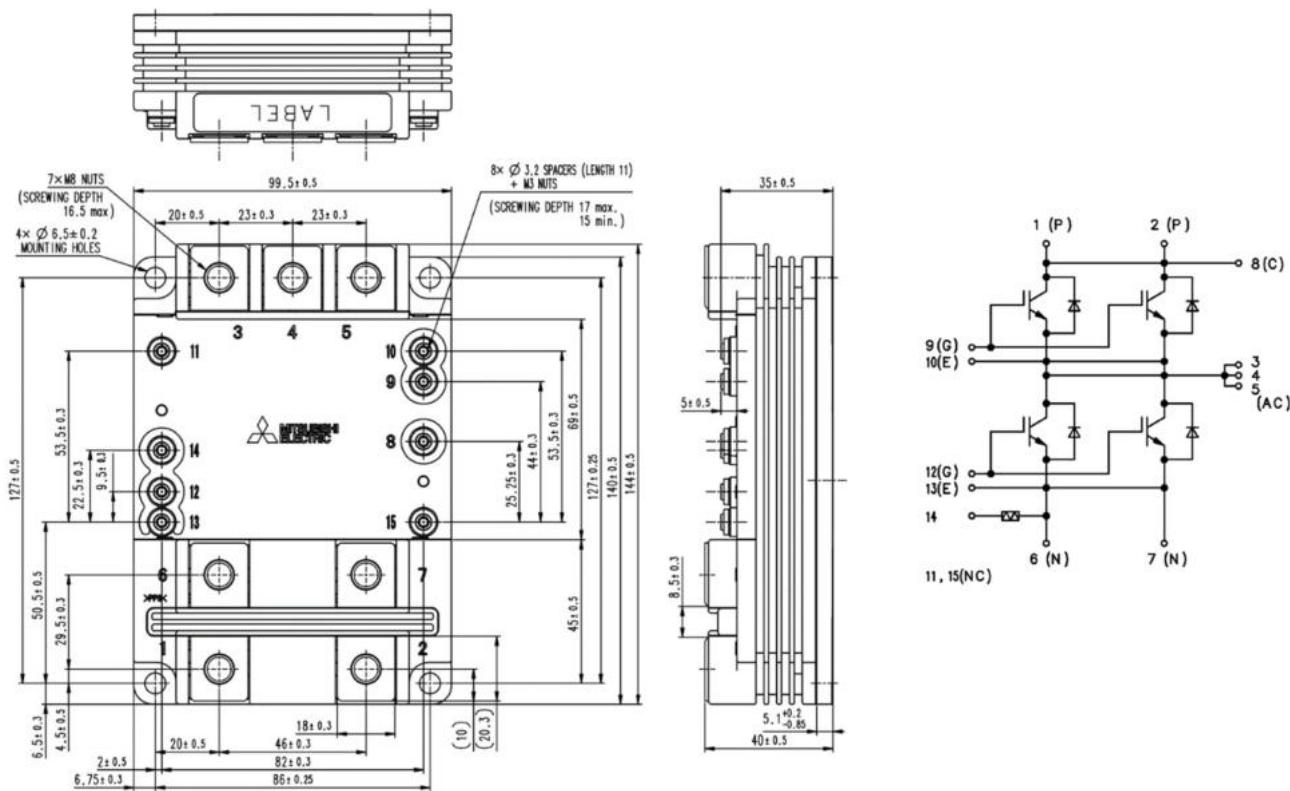
- I_C600A
- V_{CES}3300V
- 2-elements in a Pack
- Insulated Type (AlSiC base type)
- CSTBT™(III)
- SiC Schottky-Barrier Diode

APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers

OUTLINE DRAWING & CIRCUIT DIAGRAM

Dimensions in mm



MAXIMUM RATINGS

Symbol	Item	Conditions	Ratings		Unit
V_{CES}	Collector-emitter voltage	$V_{GE} = 0 \text{ V}, T_j = -40 \dots +150 \text{ }^\circ\text{C}$	3300		V
		$V_{GE} = 0 \text{ V}, T_j = -50 \text{ }^\circ\text{C}$	3200		
V_{GES}	Gate-emitter voltage	$V_{CE} = 0 \text{ V}, T_j = 25 \text{ }^\circ\text{C}$	± 20		V
I_c	Collector current	DC, $T_c = 90 \text{ }^\circ\text{C}$	600		A
		Pulse (Note 1)	1200		A
I_E	Emitter current (Note 2)	DC	600		A
		Pulse (Note 1)	1200		A
P_{tot}	Maximum power dissipation (Note 3)	$T_c = 25 \text{ }^\circ\text{C}$, IGBT part	4100		W
V_{iso}	Isolation voltage	RMS, sinusoidal, $f = 60 \text{ Hz}$, $t = 1 \text{ min}$	6000		V
Q_{PD}	Partial discharge	Charged part to the base-plate $V1 = 3500 \text{ V}_{\text{rms}}$, $V2 = 2600 \text{ V}_{\text{rms}}$ AC 60 Hz, $T_c = 25 \text{ }^\circ\text{C}$ (acc. to IEC 61287-1)	10		pC
T_j	Junction temperature	—	$-50 \dots +150$		$^\circ\text{C}$
T_{jop}	Operating junction temperature	—	$-50 \dots +150$		$^\circ\text{C}$
T_{stg}	Storage temperature	—	$-55 \dots +150$		$^\circ\text{C}$
t_{psc}	Short circuit pulse width	$V_{CC} \leq 2400 \text{ V}$, $V_{GE} = \pm 15 \text{ V}$ $R_{G(on)} = 2.2 \Omega$, $R_{G(off)} = 51 \Omega$ $T_j = 150 \text{ }^\circ\text{C}$, $C_{GE} = 33 \text{ nF}$, $L_s = 65 \text{ nH}$	10		μs

ELECTRICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit	
			Min.	Typ.	Max.		
I_{CES}	Collector cutoff current	$V_{CE} = V_{CES}$, $V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}$	—	—	2.0	
			$T_j = 125 \text{ }^\circ\text{C}$	—	2.0	—	
			$T_j = 150 \text{ }^\circ\text{C}$	—	20.0	—	
$V_{GE(th)}$	Gate-emitter threshold voltage	$V_{CE} = 10 \text{ V}$, $I_c = 60 \text{ mA}$, $T_j = 25 \text{ }^\circ\text{C}$	6.5	7.0	7.5	V	
I_{GES}	Gate leakage current	$V_{GE} = V_{GES}$, $V_{CE} = 0 \text{ V}$, $T_j = 25 \text{ }^\circ\text{C}$	-0.5	—	0.5	μA	
V_{CEsat}	Collector-emitter saturation voltage	$I_c = 600 \text{ A}$ (Note 4) $V_{GE} = 15 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}$	—	2.30	—	
			$T_j = 125 \text{ }^\circ\text{C}$	—	2.80	—	
			$T_j = 150 \text{ }^\circ\text{C}$	—	2.90	3.30	
C_{ies}	Input capacitance	$V_{CE} = 10 \text{ V}$, $V_{GE} = 0 \text{ V}$, $f = 100 \text{ kHz}$ $T_j = 25 \text{ }^\circ\text{C}$	—	53.4	—	nF	
C_{oes}	Output capacitance		—	3.8	—	nF	
C_{res}	Reverse transfer capacitance		—	0.48	—	nF	
Q_G	Total gate charge	$V_{CC} = 1800 \text{ V}$, $I_c = 600 \text{ A}$, $V_{GE} = \pm 15 \text{ V}$	—	3.6	—	μC	
$t_{d(on)}$	Turn-on delay time	$V_{CC} = 1800 \text{ V}$ $I_{C/E} = 600 \text{ A}$ $V_{GE} = \pm 15 \text{ V}$ $R_{G(on)} = 2.2 \Omega$, $C_{GE} = 33 \text{ nF}$ $L_s = 65 \text{ nH}$	$T_j = 150 \text{ }^\circ\text{C}$	—	1.25	μs	
t_r	Rise time		$T_j = 150 \text{ }^\circ\text{C}$	—	0.50	μs	
$E_{on(10\%)}$	Turn-on switching energy per pulse (Note 5)		$T_j = 25 \text{ }^\circ\text{C}$	—	0.27	—	
			$T_j = 125 \text{ }^\circ\text{C}$	—	0.29	—	
			$T_j = 150 \text{ }^\circ\text{C}$	—	0.30	—	
			$T_j = 25 \text{ }^\circ\text{C}$	—	0.29	—	
E_{on}	Turn-on switching energy per pulse		$T_j = 125 \text{ }^\circ\text{C}$	—	0.34	—	
			$T_j = 150 \text{ }^\circ\text{C}$	—	0.35	—	
			$T_j = 25 \text{ }^\circ\text{C}$	—	0.01	—	
$E_{off_diode(10\%)}$	Diode-off switching energy per pulse (Note 2, 5)	Inductive load	$T_j = 125 \text{ }^\circ\text{C}$	—	0.01	—	
			$T_j = 150 \text{ }^\circ\text{C}$	—	0.01	—	
			$T_j = 25 \text{ }^\circ\text{C}$	—	8.55	—	
$Q_{C(10\%)}$	Total capacitive charge (Note 2, 6)		$T_j = 125 \text{ }^\circ\text{C}$	—	9.25	—	
			$T_j = 150 \text{ }^\circ\text{C}$	—	10.0	—	

Symbol	Item	Conditions	Limits			Unit	
			Min.	Typ.	Max.		
V _{EC}	Emitter-collector voltage ^(Note 2)	I _E = 600 A ^(Note 4) V _{GE} = 0 V	T _j = 25 °C	—	2.25	—	
			T _j = 125 °C	—	3.55	—	
			T _j = 150 °C	—	4.55	7.00	
t _{d(off)}	Turn-off delay time	V _{CC} = 1800 V I _C = 600 A V _{GE} = ±15 V R _{G(off)} = 51 Ω C _{GE} = 33 nF L _S = 65 nH	T _j = 150 °C	—	5.00	μs	
t _f	Fall time		T _j = 150 °C	—	1.00	μs	
E _{off(10%)}	Turn-off switching energy per pulse ^(Note 5)		T _j = 25 °C	—	0.68	—	
			T _j = 125 °C	—	0.91	—	
			T _j = 150 °C	—	0.92	—	
E _{off}	Turn-off switching energy per pulse	Inductive load	T _j = 25 °C	—	0.75	—	
			T _j = 125 °C	—	1.03	—	
			T _j = 150 °C	—	1.04	—	

THERMAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
R _{th(j-c)Q}	Thermal resistance	Junction to Case, IGBT part, 1/2 module	—	—	30.0	K/kW
R _{th(j-c)D}		Junction to Case, FWDi part, 1/2 module	—	—	45.0	K/kW
R _{th(c-s)}	Contact thermal resistance	Case to heat sink, 1/2 module λ _{grease} = 1 W/m·k, D _(c-s) = 70 μm	—	16.0	—	K/kW

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
M _t	Mounting torque	Main terminals screw M8 ^(Note 7)	7.0	—	14.0	N·m
M _s		Mounting screw M6	3.0	—	6.0	N·m
M _t		Auxiliary terminals screw M3	0.4	—	0.8	N·m
m	Mass	—	—	0.80	—	Kg
CTI	Comparative tracking index	—	600	—	—	—
d _a	Clearance	Between terminals and baseplate	19.5	—	—	Mm
d _s	Creepage distance	—	32.0	—	—	Mm
L _{P(P-N)}	Parasitic stray inductance	Between terminal 1, 2 and terminal 6, 7	—	14.0	—	nH
R _{CC+EE'}	Internal lead resistance	T _c = 25 °C, 1/2 module	—	0.33	—	mΩ

NTC THERMISTOR PART

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
R ₂₅	Zero-power resistance	T _c = 25 °C	—	5.00	—	kΩ
B _(25/50)	B-constant ^(Note 8)	Approximate by equation	—	3375	—	K

Note 1. Pulse width and repetition rate should be such that junction temperature (T_j) does not exceed T_{jop_max} rating.

Note 2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD).

Note 3. Junction temperature (T_j) should not exceed T_{j_max} rating (150°C).

Note 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

Note 5. The integration range of switching energies is from 10%V_{CE} to 10%I_C(I_E).

Note 6. The integration range of total capacitive charge is from I_E=0A to 10%I_E.

Note 7 This is the case when installing the product on the bus bar.

$$\text{Note 8. } B_{(25/50)} = \ln\left(\frac{R_{25}}{R_{50}}\right) / \left(\frac{1}{T_{25}} - \frac{1}{T_{50}}\right)$$

R₂₅: resistance at 25 °C

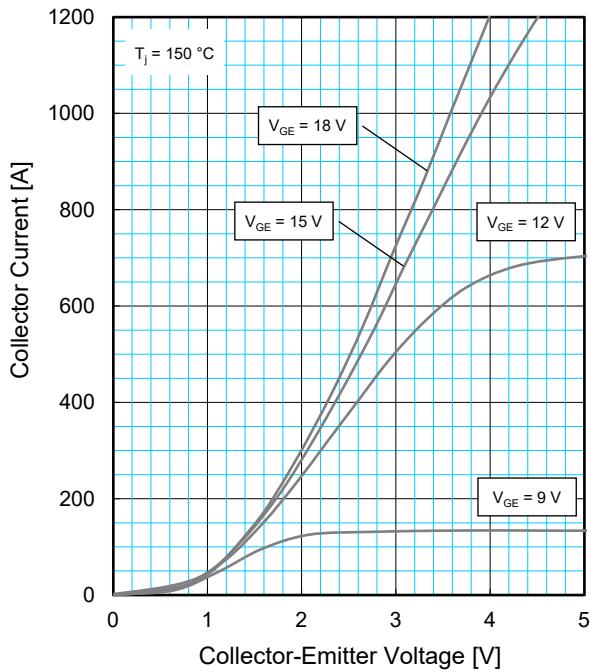
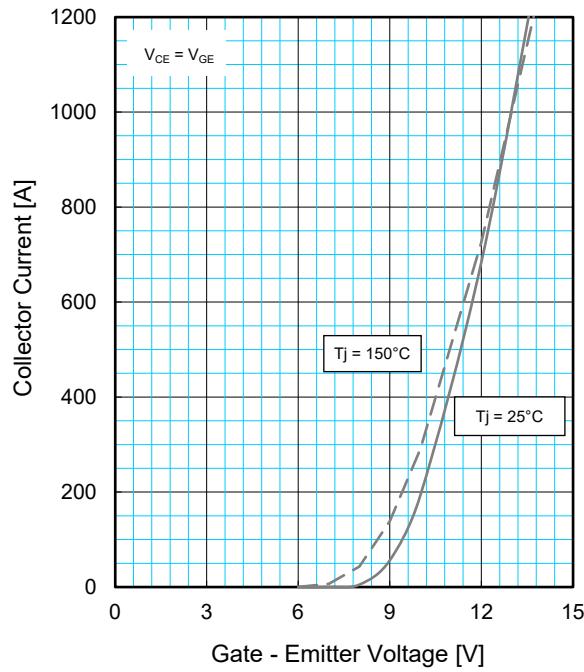
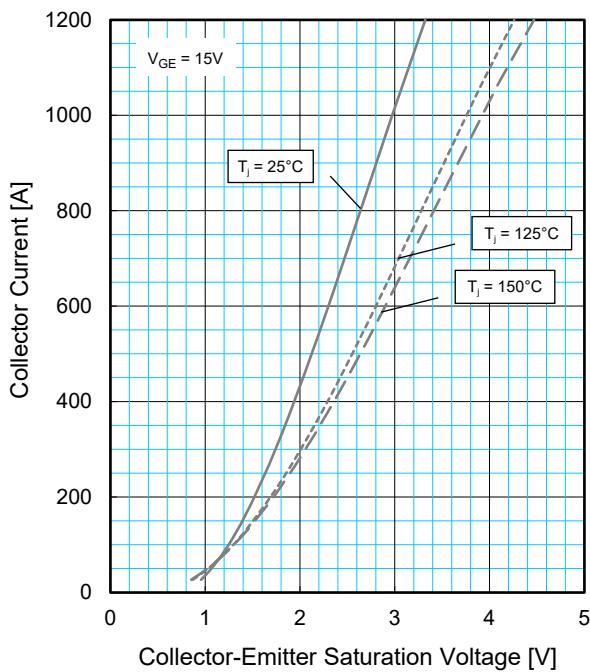
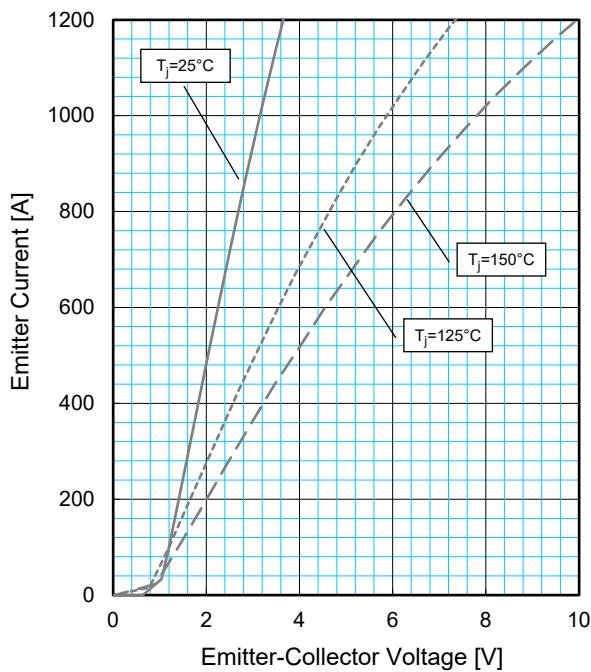
R₅₀: resistance at 50 °C

T₂₅ [K]: T₂₅ = 25 [°C] + 273.15 = 298.15 [K]

T₅₀ [K]: T₅₀ = 50 [°C] + 273.15 = 323.15 [K]

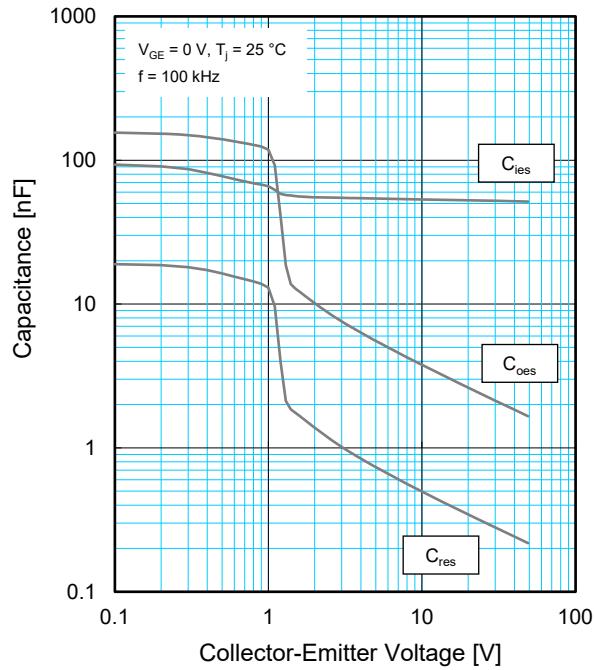
R₂₅: resistance at absolute temperature T₂₅ [K]; T₂₅ = 25 [°C] + 273.15 = 298.15 [K]

R₅₀: resistance at absolute temperature T₅₀ [K]; T₅₀ = 50 [°C] + 273.15 = 323.15 [K]

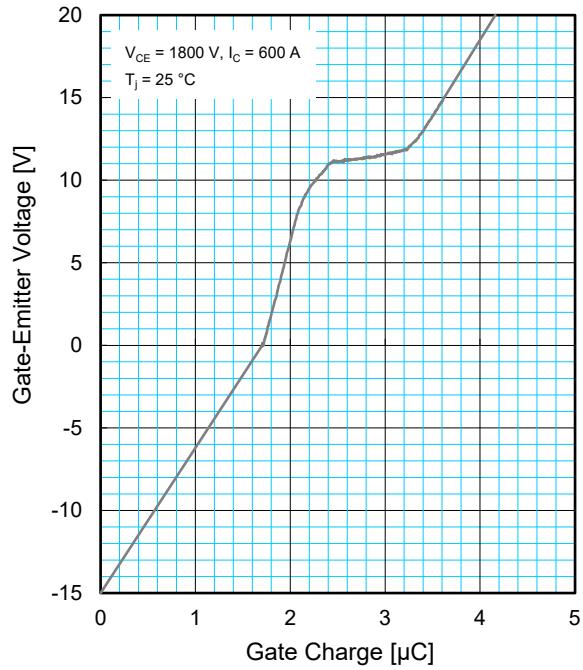
PERFORMANCE CURVES**OUTPUT CHARACTERISTICS
(TYPICAL)****TRANSFER CHARACTERISTICS
(TYPICAL)****COLLECTOR-EMITTER SATURATION VOLTAGE
CHARACTERISTICS (TYPICAL)****FREE-WHEEL DIODE FORWARD
CHARACTERISTICS (TYPICAL)**

PERFORMANCE CURVES

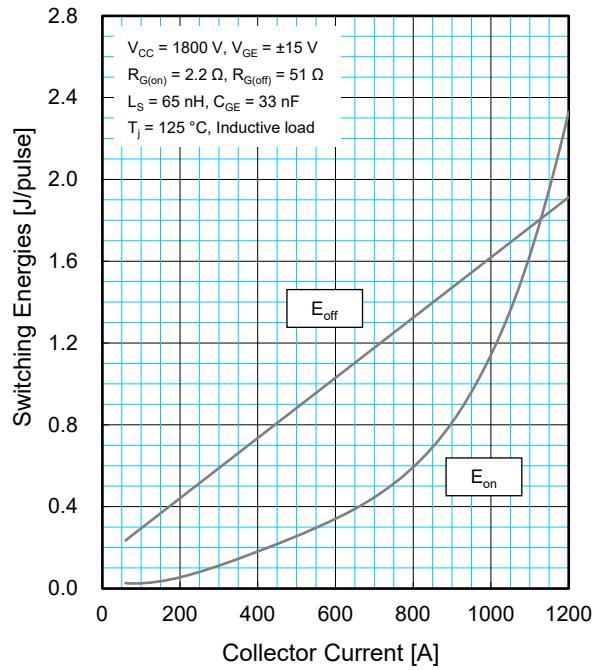
**CAPACITANCE CHARACTERISTICS
(TYPICAL)**



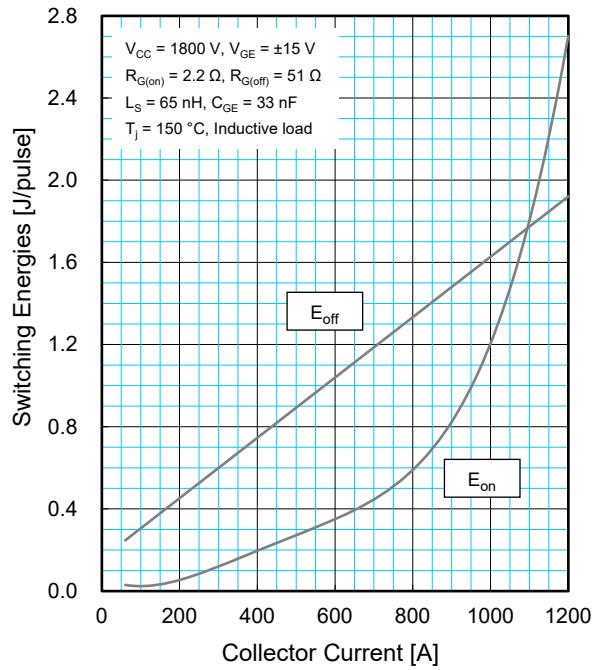
**GATE CHARGE CHARACTERISTICS
(TYPICAL)**

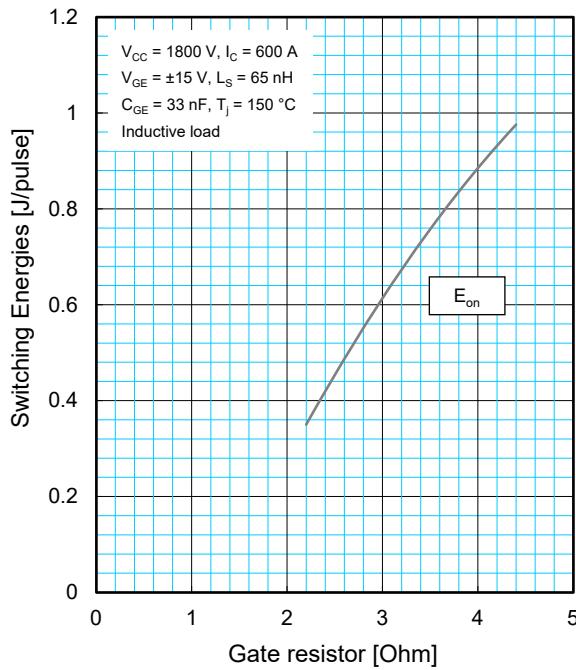
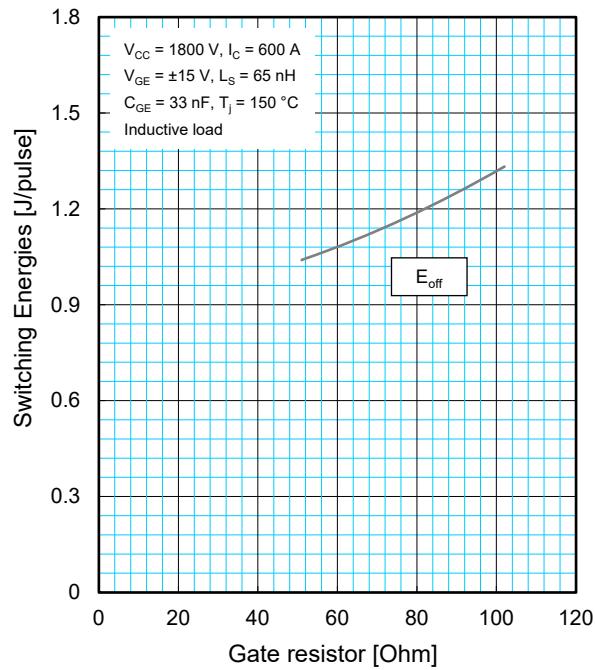
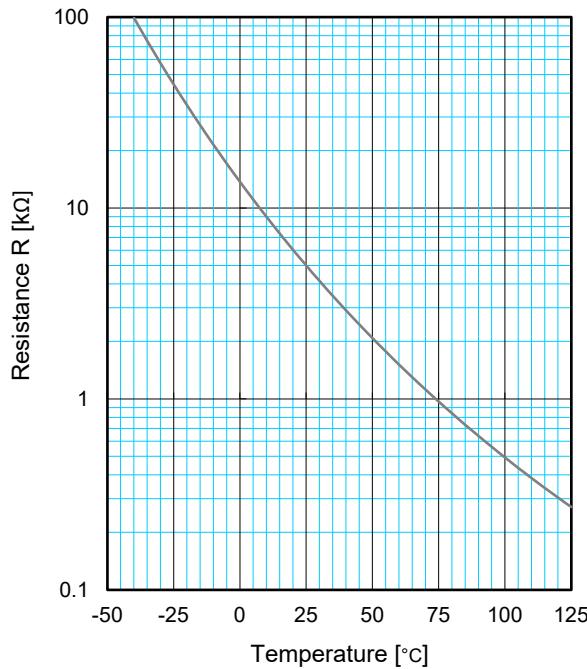


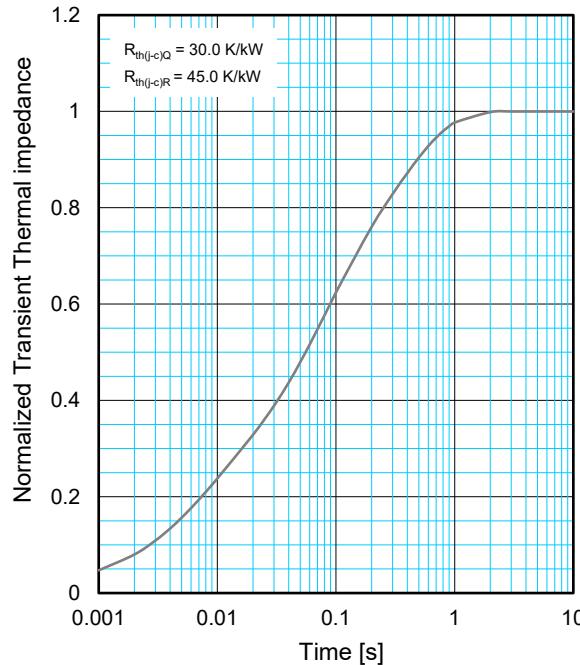
**HALF-BRIDGE SWITCHING ENERGY
CHARACTERISTICS (TYPICAL)**



**HALF-BRIDGE SWITCHING ENERGY
CHARACTERISTICS (TYPICAL)**

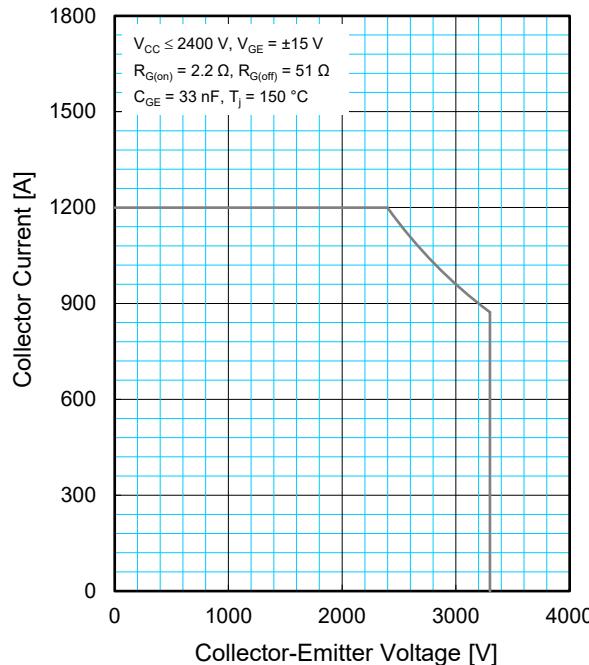
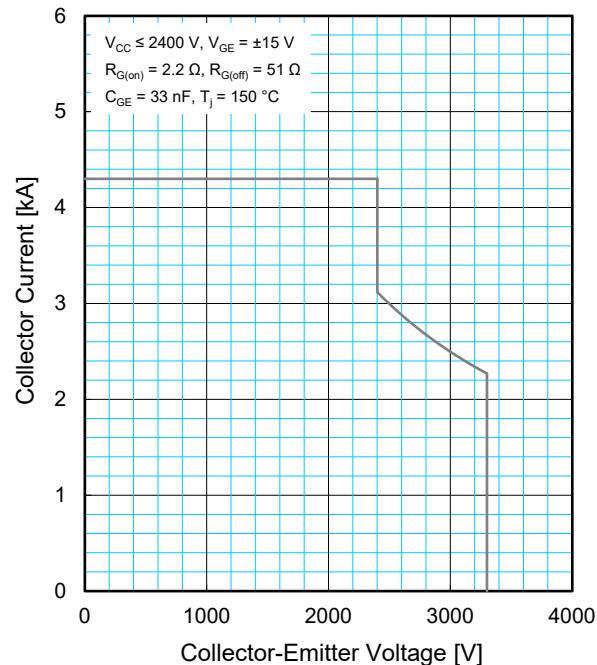


PERFORMANCE CURVES**HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)****HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)****NTC THERMISTOR TEMPERATURE CHARACTERISTICS (TYPICAL)**

PERFORMANCE CURVES**TRANSIENT THERMAL IMPEDANCE
CHARACTERISTICS**

$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i \left\{ 1 - \exp\left(-\frac{t}{\tau_i}\right) \right\}$$

	1	2	3	4
$R_i / R_{th(j-c)}$	0.0096	0.1893	0.4044	0.3967
τ_i [s]	0.0001	0.0058	0.0602	0.3512

**REVERSE BIAS SAFE OPERATING AREA
(RBSOA)****SHORT CIRCUIT
SAFE OPERATING AREA (SCSOA)**

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